Applicant(s)/Patent Under Application/Control No. Reexamination 10/612,444 QIAN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1756 Mark A. Chapman **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY US-5,302,482 04-1994 Α Elmasry et al. 430/115 US-4,988,602 01-1991 Jongewaard et al. 430/115 В US-Ç US-D US-Ε F US-US-G

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